Designer's™ Data Sheet

TMOS E-FET™ High Energy Power FET D2PAK for Surface Mount

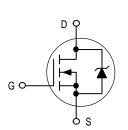
N-Channel Enhancement-Mode Silicon Gate

The D²PAK package has the capability of housing a larger die than any existing surface mount package which allows it to be used in applications that require the use of surface mount components with higher power and lower R_{DS(on)} capabilities. This advanced TMOS E-FET is designed to withstand high energy in the avalanche and commutation modes. The new energy efficient design also offers a drain-to-source diode with a fast recovery time. Designed for low voltage, high speed switching applications in power supplies, converters and PWM motor controls, these devices are particularly well suited for bridge circuits where diode speed and commutating safe operating areas are critical and offer additional safety margin against unexpected voltage transients.

- · Avalanche Energy Specified
- Source-to-Drain Diode Recovery Time Comparable to a Discrete Fast Recovery Diode
- · Diode is Characterized for Use in Bridge Circuits
- IDSS and VDS(on) Specified at Elevated Temperature
- Short Heatsink Tab Manufactured Not Sheared
- Specially Designed Leadframe for Maximum Power Dissipation
- Available in 24 mm 13-inch/800 Unit Tape & Reel, Add T4 Suffix to Part Number

MTB15N06E Motorola Preferred Device

TMOS POWER FET 15 AMPERES RDS(on) = 0.12 OHM 60 VOLTS





MAXIMUM RATINGS (T_C = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-Source Voltage	VDSS	60	Vdc
Drain–Gate Voltage (R _{GS} = 1.0 M Ω)	VDGR	60	Vdc
Gate-Source Voltage — Continuous	VGS	±20	Vdc
Drain Current — Continuous — Continuous @ 100°C — Single Pulse (t _p ≤ 10 μs)	I _D	15 10 40	Adc Apk
Total Power Dissipation Derate above 25°C Total Power Dissipation @ T _A = 25°C, when mounted with the minimum recommended pad size	PD	75 0.6 2.5	Watts W/°C Watts
Operating and Storage Temperature Range	TJ, T _{stg}	-55 to 150	°C
Single Pulse Drain–to–Source Avalanche Energy — Starting T _J = 25° C (V _{DD} = 25 Vdc, V _{GS} = 10 Vpk, I _L = 15 Apk, L = 0.98 mH, R _G = 25 Ω)	EAS	110	mJ
Thermal Resistance — Junction to Case — Junction to Ambient — Junction to Ambient, when mounted with the minimum recommended pad size	R _θ JC R _θ JA R _θ JA	1.67 62.5 50	°C/W
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds	TL	260	°C

Designer's Data for "Worst Case" Conditions — The Designer's Data Sheet permits the design of most circuits entirely from the information presented. SOA Limit curves — representing boundaries on device characteristics — are given to facilitate "worst case" design.

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Preferred devices are Motorola recommended choices for future use and best overall value.

REV 1



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$\textbf{ELECTRICAL CHARACTERISTICS} \ (T_J = 25^{\circ}\text{C unless otherwise noted})$

Cha	Symbol	Min	Тур	Max	Unit		
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage (V _{GS} = 0 V, I _D = 250 μAdc) Temperature Coefficient (Positive	V(BR)DSS	60 —	— 64	_	Vdc mV/°C		
Zero Gate Voltage Drain Current (V _{DS} = 60 Vdc, V _{GS} = 0) (V _{DS} = 60 Vdc, V _{GS} = 0, T _J = 1)	IDSS		_	10 100	μAdc		
Gate-Body Leakage Current (VGS	IGSS	_	_	100	nAdc		
ON CHARACTERISTICS (1)				•		•	
Gate Threshold Voltage (V _{DS} = V _{GS} , I _D = 250 μAdc) Temperature Coefficient (Negativ	VGS(th)	2.0 —	2.9 6.0	4.0 —	Vdc mV/°C		
Static Drain-Source On-Resistance	R _{DS(on)}	_	0.1	0.12	Ohm		
Drain-Source On-Voltage (V_{GS} = (I_D = 15 Adc) (I_D = 7.5 Adc, T_J = 125°C)	V _{DS(on)}	_ _	_	2.16 1.8	Vdc		
Forward Transconductance (V _{DS} ≥	9FS	4.0	6.5	_	mhos		
DYNAMIC CHARACTERISTICS							
Input Capacitance		C _{iss}	_	500	700	pF	
Output Capacitance	(V _{DS} = 25 Vdc, V _{GS} = 0, f = 1.0 MHz)	C _{oss}	_	240	340		
Reverse Transfer Capacitance	,	C _{rss}	_	60	120		
SWITCHING CHARACTERISTICS (2)						
Turn-On Delay Time		t _{d(on)}	_	8.0	16	ns	
Rise Time	$(V_{DD} = 30 \text{ Vdc}, I_{D} = 15 \text{ Adc}, V_{GS} = 10 \text{ Vdc},$	t _r	_	70	140		
Turn-Off Delay Time	$R_G = 9.0 \Omega$	t _{d(off)}	_	16	32		
Fall Time		t _f	_	40	80		
Gate Charge	(V _{DS} = 48 Vdc, I _D = 15 Adc, V _{GS} = 10 Vdc)	QT	_	15	35	nC	
		Q ₁	_	3.0	_		
		Q ₂	_	8.0	_		
		Q ₃	_	6.0	_		
SOURCE-DRAIN DIODE CHARAC	FERISTICS	•		•		•	
Forward On-Voltage	$(I_S = 15 \text{ Adc}, V_{GS} = 0)$ $(I_S = 15 \text{ Adc}, V_{GS} = 0, T_J = 125^{\circ}\text{C})$	V _{SD}	_	1.1 0.97	1.6 —	Vdc	
Reverse Recovery Time	$(I_S = 15 \text{ Adc}, V_{GS} = 0, \\ dI_S/dt = 100 \text{ A/}\mu\text{s})$	t _{rr}	_	70	_	ns	
NTERNAL PACKAGE INDUCTANO	E						
Internal Drain Inductance (Measured from the tab to center	L _D	_	3.5	_	nH		
Internal Source Inductance (Measured from the source lead	LS	_	7.5	_	nH		

⁽¹⁾ Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
(2) Switching characteristics are independent of operating junction temperature.

TYPICAL ELECTRICAL CHARACTERISTICS

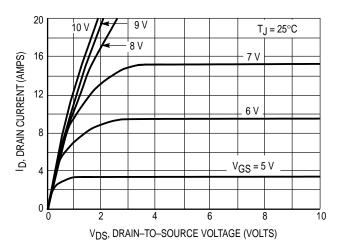


Figure 1. On-Region Characteristics

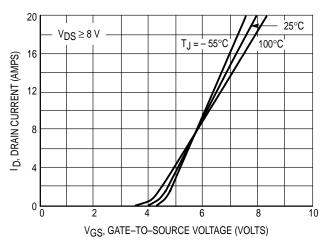


Figure 2. Transfer Characteristics

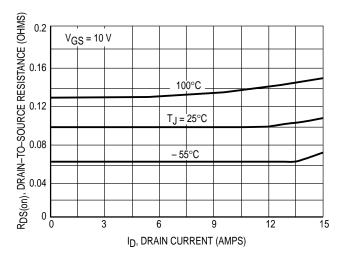


Figure 3. On–Resistance versus Drain Current and Temperature

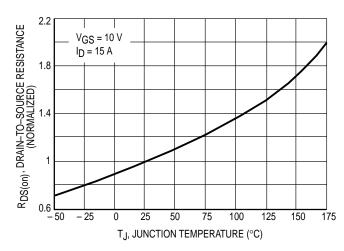


Figure 4. On–Resistance Variation With Temperature

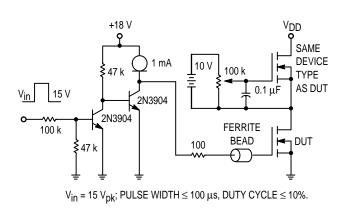


Figure 5. Gate Charge Test Circuit

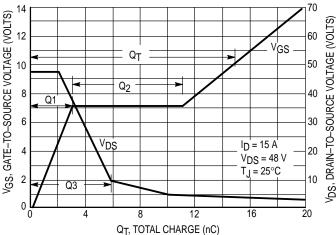


Figure 6. Gate-to-Source and Drain-to-Source Voltage versus Total Charge

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POWER MOSFET SWITCHING

Switching behavior is most easily modeled and predicted by recognizing that the power MOSFET is charge controlled. The lengths of various switching intervals (Δt) are determined by how fast the FET input capacitance can be charged by current from the generator.

The published capacitance data is difficult to use for calculating rise and fall because drain—gate capacitance varies greatly with applied voltage. Accordingly, gate charge data is used. In most cases, a satisfactory estimate of average input current ($I_{G(AV)}$) can be made from a rudimentary analysis of the drive circuit so that

 $t = Q/I_{G(AV)}$

During the rise and fall time interval when switching a resistive load, VGS remains virtually constant at a level known as the plateau voltage, VSGP. Therefore, rise and fall times may be approximated by the following:

 $t_r = Q_2 \times R_G/(V_{GG} - V_{GSP})$

 $t_f = Q_2 \times R_G/V_{GSP}$

where

 V_{GG} = the gate drive voltage, which varies from zero to V_{GG} R_{G} = the gate drive resistance

and Q2 and VGSP are read from the gate charge curve.

During the turn—on and turn—off delay times, gate current is not constant. The simplest calculation uses appropriate values from the capacitance curves in a standard equation for voltage change in an RC network. The equations are:

 $t_{d(on)} = R_G C_{iss} In [V_{GG}/(V_{GG} - V_{GSP})]$

 $t_{d(off)} = R_G C_{iss} In (V_{GG}/V_{GSP})$

The capacitance (C_{iss}) is read from the capacitance curve at a voltage corresponding to the off–state condition when calculating $t_{d(on)}$ and is read at a voltage corresponding to the on–state when calculating $t_{d(off)}$.

At high switching speeds, parasitic circuit elements complicate the analysis. The inductance of the MOSFET source lead, inside the package and in the circuit wiring which is common to both the drain and gate current paths, produces a voltage at the source which reduces the gate drive current. The voltage is determined by Ldi/dt, but since di/dt is a function of drain current, the mathematical solution is complex. The MOSFET output capacitance also complicates the mathematics. And finally, MOSFETs have finite internal gate resistance which effectively adds to the resistance of the driving source, but the internal resistance is difficult to measure and, consequently, is not specified.

The resistive switching time variation versus gate resistance (Figure 8) shows how typical switching performance is affected by the parasitic circuit elements. If the parasitics were not present, the slope of the curves would maintain a value of unity regardless of the switching speed. The circuit used to obtain the data is constructed to minimize common inductance in the drain and gate circuit loops and is believed readily achievable with board mounted components. Most power electronic loads are inductive; the data in the figure is taken with a resistive load, which approximates an optimally snubbed inductive load. Power MOSFETs may be safely operated into an inductive load; however, snubbing reduces switching losses.

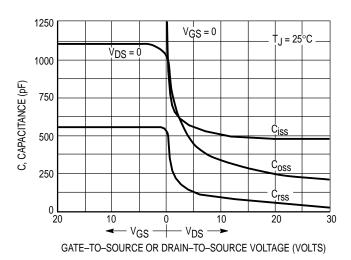


Figure 7. Capacitance Variation

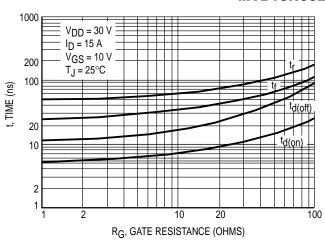


Figure 8. Resistive Switching Time Variation versus Gate Resistance

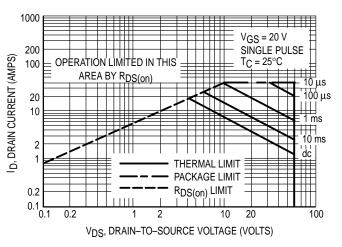


Figure 9. Maximum Rated Forward Biased Safe Operating Area

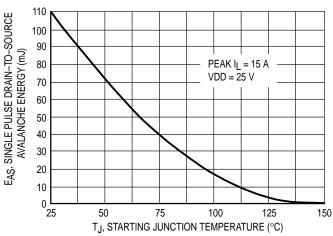


Figure 10. Maximum Avalanche Energy versus Starting Junction Temperature

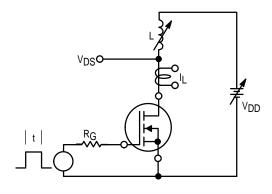


Figure 11. Unclamped Inductive Switching
Test Circuit

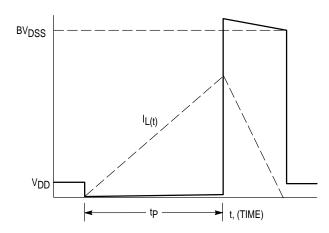


Figure 12. Unclamped Inductive Switching Waveforms

SAFE OPERATING AREA INFORMATION

FORWARD BIASED SAFE OPERATING AREA

The FBSOA curves define the maximum drain–to–source voltage and drain current that a device can safely handle when it is forward biased, or when it is on, or being turned on. Because these curves include the limitations of simultaneous high voltage and high current, up to the rating of the device, they are especially useful to designers of linear systems. The

curves are based on a case temperature of 25°C and a maximum junction temperature of 150°C. Limitations for repetitive pulses at various case temperatures can be determined by using the thermal response curves. Motorola Application Note, AN569, "Transient Thermal Resistance–General Data and Its Use" provides detailed instructions.

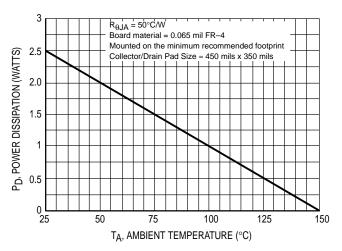


Figure 13. D²PAK Power Derating Curve

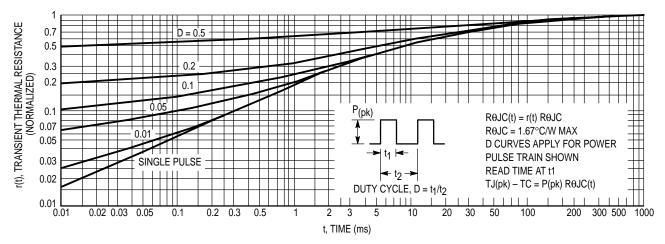
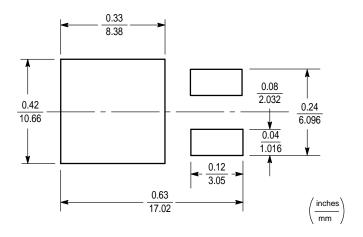


Figure 14. Thermal Response

INFORMATION FOR USING THE D2PAK SURFACE MOUNT PACKAGE

RECOMMENDED FOOTPRINT FOR SURFACE MOUNTED APPLICATIONS

Surface mount board layout is a critical portion of the total design. The footprint for the semiconductor packages must be the correct size to ensure proper solder connection interface between the board and the package. With the correct pad geometry, the packages will self align when subjected to a solder reflow process.



POWER DISSIPATION FOR A SURFACE MOUNT DEVICE

The power dissipation for a surface mount device is a function of the drain pad size. These can vary from the minimum pad size for soldering to a pad size given for maximum power dissipation. Power dissipation for a surface mount device is determined by $T_{J(max)}$, the maximum rated junction temperature of the die, $R_{\theta JA}$, the thermal resistance from the device junction to ambient, and the operating temperature, T_A . Using the values provided on the data sheet, P_D can be calculated as follows:

$$P_D = \frac{T_{J(max)} - T_A}{R_{\theta JA}}$$

The values for the equation are found in the maximum ratings table on the data sheet. Substituting these values into the equation for an ambient temperature T_A of 25°C, one can calculate the power dissipation of the device. For a D²PAK device, P_D is calculated as follows.

$$P_D = \frac{150^{\circ}C - 25^{\circ}C}{50^{\circ}C/W} = 2.5 \text{ Watts}$$

The 50° C/W for the D²PAK package assumes the use of the recommended footprint on a glass epoxy printed circuit board to achieve a power dissipation of 2.5 Watts. There are other alternatives to achieving higher power dissipation from the surface mount packages. One is to increase the area of the drain pad. By increasing the area of the drain pad, the power

dissipation can be increased. Although one can almost double the power dissipation with this method, one will be giving up area on the printed circuit board which can defeat the purpose of using surface mount technology. For example, a graph of $R_{\theta,IA}$ versus drain pad area is shown in Figure 15.

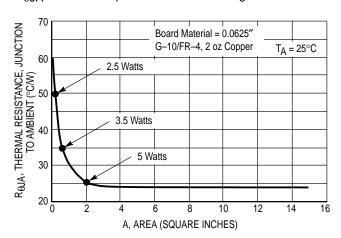


Figure 15. Thermal Resistance versus Drain Pad Area for the D²PAK Package (Typical)

Another alternative would be to use a ceramic substrate or an aluminum core board such as Thermal Clad™. Using a board material such as Thermal Clad, an aluminum core board, the power dissipation can be doubled using the same footprint.

SOLDER STENCIL GUIDELINES

Prior to placing surface mount components onto a printed circuit board, solder paste must be applied to the pads. Solder stencils are used to screen the optimum amount. These stencils are typically 0.008 inches thick and may be made of brass or stainless steel. For packages such as the SC–59, SC–70/SOT–323, SOD–123, SOT–23, SOT–143, SOT–223, SO–8, SO–14, SO–16, and SMB/SMC diode packages, the stencil opening should be the same as the pad size or a 1:1 registration. This is not the case with the DPAK and D²PAK packages. If one uses a 1:1 opening to screen solder onto the drain pad, misalignment and/or "tombstoning" may occur due to an excess of solder. For these two packages, the opening in the stencil for the paste should be approximately 50% of the tab area. The opening for the leads is still a 1:1 registration. Figure 16 shows a typical stencil for the DPAK and D²PAK

packages. The pattern of the opening in the stencil for the drain pad is not critical as long as it allows approximately 50% of the pad to be covered with paste.

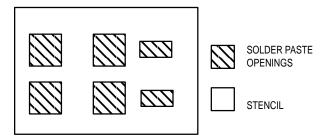


Figure 16. Typical Stencil for DPAK and D2PAK Packages

SOLDERING PRECAUTIONS

The melting temperature of solder is higher than the rated temperature of the device. When the entire device is heated to a high temperature, failure to complete soldering within a short time could result in device failure. Therefore, the following items should always be observed in order to minimize the thermal stress to which the devices are subjected.

- Always preheat the device.
- The delta temperature between the preheat and soldering should be 100°C or less.*
- When preheating and soldering, the temperature of the leads and the case must not exceed the maximum temperature ratings as shown on the data sheet. When using infrared heating with the reflow soldering method, the difference shall be a maximum of 10°C.
- The soldering temperature and time shall not exceed 260°C for more than 10 seconds.

- When shifting from preheating to soldering, the maximum temperature gradient shall be 5°C or less.
- After soldering has been completed, the device should be allowed to cool naturally for at least three minutes.
 Gradual cooling should be used as the use of forced cooling will increase the temperature gradient and result in latent failure due to mechanical stress.
- Mechanical stress or shock should not be applied during cooling.
- Soldering a device without preheating can cause excessive thermal shock and stress which can result in damage to the device.
- * Due to shadowing and the inability to set the wave height to incorporate other surface mount components, the D²PAK is not recommended for wave soldering.

TYPICAL SOLDER HEATING PROFILE

For any given circuit board, there will be a group of control settings that will give the desired heat pattern. The operator must set temperatures for several heating zones, and a figure for belt speed. Taken together, these control settings make up a heating "profile" for that particular circuit board. On machines controlled by a computer, the computer remembers these profiles from one operating session to the next. Figure 17 shows a typical heating profile for use when soldering a surface mount device to a printed circuit board. This profile will vary among soldering systems but it is a good starting point. Factors that can affect the profile include the type of soldering system in use, density and types of components on the board, type of solder used, and the type of board or substrate material being used. This profile shows temperature versus time. The

line on the graph shows the actual temperature that might be experienced on the surface of a test board at or near a central solder joint. The two profiles are based on a high density and a low density board. The Vitronics SMD310 convection/infrared reflow soldering system was used to generate this profile. The type of solder used was 62/36/2 Tin Lead Silver with a melting point between 177–189°C. When this type of furnace is used for solder reflow work, the circuit boards and solder joints tend to heat first. The components on the board are then heated by conduction. The circuit board, because it has a large surface area, absorbs the thermal energy more efficiently, then distributes this energy to the components. Because of this effect, the main body of a component may be up to 30 degrees cooler than the adjacent solder joints.

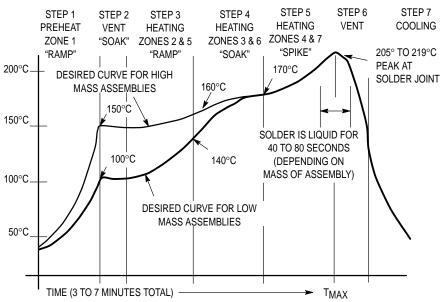
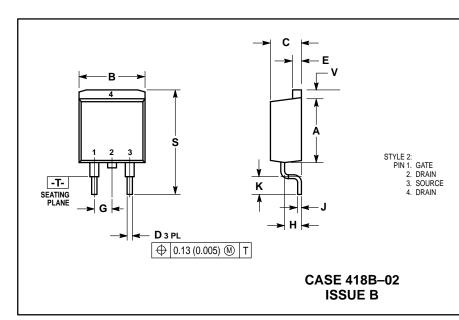


Figure 17. Typical Solder Heating Profile

PACKAGE DIMENSIONS



NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M. 1982.
- 2. CONTROLLING DIMENSION: INCH.

	INC	HES	MILLIN	IETEDE	
	_		MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.340	0.380	8.64	9.65	
В	0.380	0.405	9.65	10.29	
С	0.160	0.190	4.06	4.83	
D	0.020	0.035	0.51	0.89	
E	0.045	0.055	1.14	1.40	
G	0.100 BSC		2.54 BSC		
Н	0.080	0.110	2.03	2.79	
J	0.018	0.025	0.46	0.64	
K	0.090	0.110	2.29	2.79	
S	0.575	0.625	14.60	15.88	
V	0.045	0.055	1.14	1.40	

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